Application/Control No. Applicant(s)/Patent Under Reexamination 10/791,135 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2831 Jinhee J. Lee **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY US-2001/0040705 11-2001 Yokota, Masahiko 358/474 Α US-5,791,853 08-1998 Danielson et al. 414/280 В С US-US-D US-Ε US-F US-G Н US-US-1 US-J US-Κ US-L US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Country Code-Number-Kind Code Classification MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W